

| | | | | |
|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/682,199 | HERMENTIN ET AL. | |
| Examiner | | David J Vinci | Art Unit | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,521,111 | 02-2003 | Amshey et al. | 204/616 |
| | B | US-6,090,255 | 07-2000 | Riley et al. | 204/606 |
| | C | US-5,549,806 | 08-1996 | Chen, Stephen L. | 204/616 |
| | D | US-5,458,760 | 10-1995 | Kozulic, Branko | 204/616 |
| | E | US-5,259,943 | 11-1993 | Kozulic et al. | 204/616 |
| | F | US-4,465,574 | 08-1984 | Mattock et al. | 204/545 |
| | G | US-4,250,008 | 02-1981 | Mattock, Patrick | 204/545 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.